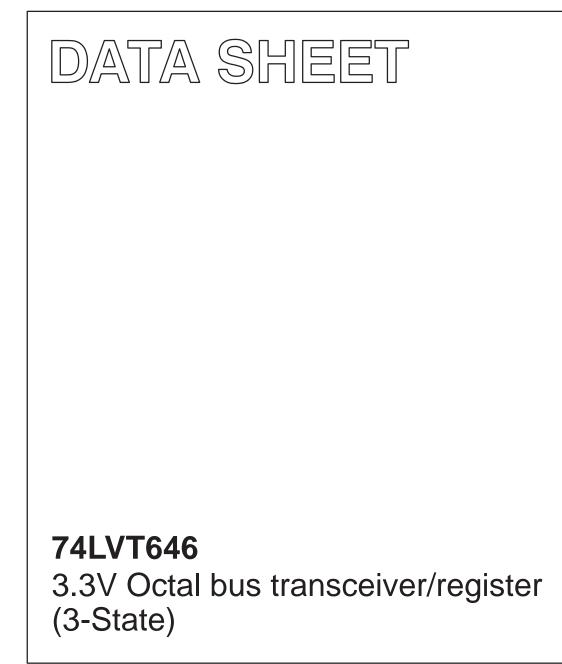
INTEGRATED CIRCUITS



Product specification Supersedes data of 1994 May 20 IC23 Data Handbook 1998 Feb 19



Philips Semiconductors

74LVT646

FEATURES

- Combines 74LVT245 and 74LVT574 type functions in one device
- Independent registers for A and B buses
- Multiplexed real-time and stored data
- Output capability: +64mA/-32mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- No bus current loading when output is tied to 5V bus
- Latch-up protection exceeds 500mA per JEDEC Std 17
- Power-up 3-State
- Power-up reset
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model

DESCRIPTION

The LVT646 is a high-performance BiCMOS product designed for V_{CC} operation at 3.3V.

This device consists of bus transceiver circuits with 3-State outputs, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the input bus or the internal registers.

Data on the A or B bus will be clocked into the registers as the appropriate clock pin goes High.

Output Enable (\overline{OE}) and DIR pins are provided to control the transceiver function. In the transceiver mode, data present at the high impedance port may be stored in either the A or B register or both.

The Select (SAB, SBA) pins determine whether data is stored or transferred through the device in real-time. The DIR determines which bus will receive data when the \overline{OE} is active (Low).

In the isolation mode (\overline{OE} = High), data from Bus A may be stored in the B register and/or data from Bus B may be stored in the A register.

When an output function is disabled, the input function is still enabled and may be used to store and transmit data. Only one of the two buses, A or B may be driven at a time. The examples on the next page demonstrate the four fundamental bus management functions that can be performed with the 74LVT646.

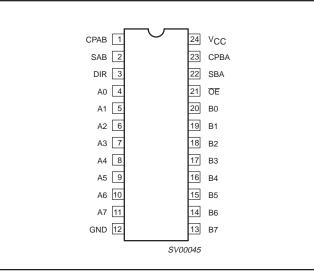
QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS T _{amb} = 25°C; GND = 0V	TYPICAL	UNIT
t _{PLH} t _{PHL}	Propagation delay An to Bn or Bn to An	$C_{L} = 50 pF; V_{CC} = 3.3 V$	2.8 2.7	ns
C _{IN}	Input capacitance CP, S, OE, DIR	$V_{I/O} = 0V \text{ or } 3.0V$	4	pF
C _{I/O}	I/O capacitance	Outputs disabled; $V_{I/O} = 0V$ or 3.0V	10	pF
I _{CCZ}	Total supply current	Outputs disabled; $V_{CC} = 3.6V$	0.13	mA

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
24-Pin Plastic SOL	-40°C to +85°C	74LVT646 D	74LVT646 D	SOT163-1
24-Pin Plastic SSOP Type II	-40°C to +85°C	74LVT646 DB	74LVT646 DB	SOT399-1
24-Pin Plastic TSSOP Type I	-40°C to +85°C	74LVT646 PW	74LVT646PW DH	SOT360-1

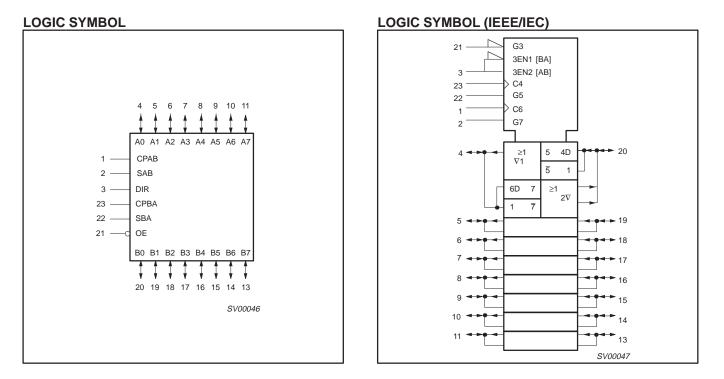
PIN CONFIGURATION



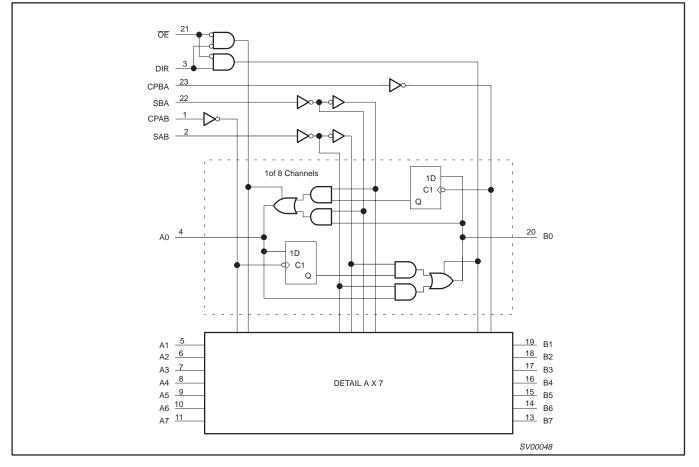
PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
1, 23	CPAB / CPBA	A to B clock input / B to A clock input
2, 22	SAB / SBA	A to B select input / B to A select input
3	DIR	Direction control input
4, 5, 6, 7, 8, 9, 10, 11	A0 – A7	Data inputs/outputs (A side)
20, 19, 18, 17, 16, 15, 14, 13	B0 – B7	Data inputs/outputs (B side)
21	ŌĒ	Output enable input (active-low)
12	GND	Ground (0V)
24	V _{CC}	Positive supply voltage

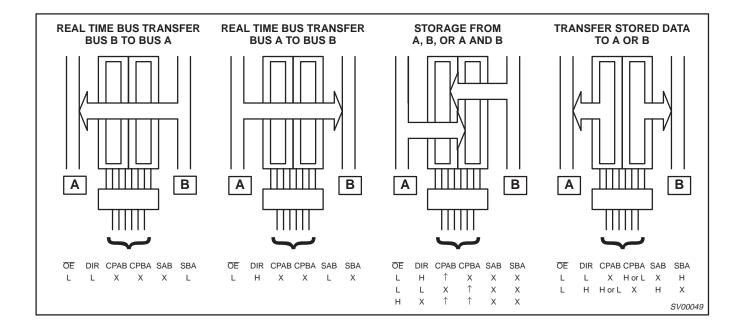
74LVT646



LOGIC DIAGRAM



74LVT646



FUNCTION TABLE

		INPUT	5			DATA I/O		OPERATING MODE
ŌĒ	DIR	CPAB	СРВА	SAB	SBA	An	Bn	OFERATING MODE
х	х	Ŷ	Х	х	Х	Input	Unspecified output*	Store A, B unspecified
х	х	х	Ŷ	х	Х	Unspecified output*	Input	Store B, A unspecified
H H	X X	↑ H or L	↑ H or L	X X	X X	Input	Input	Store A and B data Isolation, hold storage
L	L L	X X	X H or L	X X	L H	Output	Input	Real time B data to A bus Stored B data to A bus
L	H H	X H or L	X X	L H	X X	Input	Output	Real time A data to B bus Stored A data to B bus

H = High voltage level L = Low voltage level

X ↑ = Don't care

Low-to-High clock transition =

The data output function may be enabled or disabled by various signals at the OE input. Data input functions are always enabled, i.e., data at the bus pins will be stored on every Low-to-High transition of the clock.

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ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V
I _{IK}	DC input diode current	V ₁ < 0	-50	mA
VI	DC input voltage ³		-0.5 to +7.0	V
Ι _{ΟΚ}	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	Output in Off or High state	-0.5 to +7.0	V
		Output in Low state	128	
IOUT	DC output current	Output in High state	-64	mA
T _{stg}	Storage temperature range		-65 to 150	°C

NOTES:

Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

CYMDOL	DADAMETED	LIM		
SYMBOL	PARAMETER	MIN	MAX	UNIT
V _{CC}	DC supply voltage	2.7	3.6	V
VI	Input voltage	0	5.5	V
VIH	High-level input voltage	2.0		V
V _{IL}	Input voltage		0.8	V
I _{OH}	High-level output current		-32	mA
1	Low-level output current		32	A
I _{OL}	Low-level output current; current duty cycle \leq 50%, f \geq 1kHz		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate; Outputs enabled		10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	°C

Product specification

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3.3V Octal bus transceiver/register (3-State)

DC ELECTRICAL CHARACTERISTICS

					LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS	Temp = -40°C to +85°C				
				MIN	TYP NO TAG	МАХ	
VIK	Input clamp voltage	V _{CC} = 2.7V; I _{IK} = -18mA			-0.9	-1.2	V
		$V_{CC} = 2.7$ to 3.6V; $I_{OH} = -100\mu A$		V _{CC} -0.2	V _{CC} -0.1		
V _{OH}	High-level output voltage	$V_{CC} = 2.7V; I_{OH} = -8mA$		2.4	2.5		V
		V _{CC} = 3.0V; I _{OH} = -32mA		2.0	2.2		
		V _{CC} = 2.7V; I _{OL} = 100μA			0.1	0.2	
		V _{CC} = 2.7V; I _{OL} = 24mA			0.3	0.5	
V _{OL}	Low-level output voltage	V _{CC} = 3.0V; I _{OL} = 16mA			0.25	0.4	V
		V _{CC} = 3.0V; I _{OL} = 32mA			0.3	0.5	
		V _{CC} = 3.0V; I _{OL} = 64mA			0.4	0.55	
V _{RST}	Power-up output low voltage ⁵	V_{CC} = 3.6V; I _O = 1mA; V _I = GND or V _{CC}	;		0.13	0.55	V
		$V_{CC} = 3.6V; V_I = V_{CC} \text{ or } GND$			±0.1	±1	
		$V_{CC} = 0 \text{ or } 3.6 \text{V}; \text{ V}_{\text{I}} = 5.5 \text{V}$	Control pins		1	10	
I	Input leakage current	$V_{CC} = 3.6V; V_1 = 5.5V$			1	20	μΑ
		$V_{CC} = 3.6V; V_{I} = V_{CC}$	I/O Data pins ⁴		0.1	1	
		$V_{CC} = 3.6V; V_{I} = 0$			-1	-5	
I _{OFF}	Output off current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$	-		1	±100	μΑ
		$V_{CC} = 3V; V_I = 0.8V$		75	150		
I _{HOLD}	Bus Hold current A inputs ⁶	$V_{CC} = 3V; V_I = 2.0V$		-75	-150		μA
I _{EX}	Current into an output in the High state when $V_O > V_{CC}$	$V_{CC} = 0V \text{ to } 3.6V; V_{CC} = 3.6V$ $V_{O} = 5.5V; V_{CC} = 3.0V$		±500	60	125	μΑ
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2V$; $V_O = 0.5V$ to V_{CC} ; $V_I = GND$ or V_{CC} ; OE/OE =Don't care			15	±100	μA
ICCH		V_{CC} = 3.6V; Outputs High, V_{I} = GND or V_{CC} , I_{O} = 0			0.13	0.19	
I _{CCL}	Quiescent supply current	V_{CC} = 3.6V; Outputs Low, V_I = GND or V_{CC} , I_O = 0			3	12	mA
I _{CCZ}	1	V_{CC} = 3.6V; Outputs Disabled; V_{I} = GN	O or V_{CC} , $I_{O} = 0$		0.13	0.19	1
ΔI_{CC}	Additional supply current per input pin ²	V_{CC} = 3V to 3.6V; One input at V_{CC} -0.6 Other inputs at V_{CC} or GND	V,		0.1	0.2	mA

NOTES:

NOTES:
All typical values are at and T_{amb} = 25°C.
This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 3.3V ± 0.3V a transition time of 100µsec is permitted. This parameter is valid for T_{amb} = 25°C only.
Unused pins at V_{CC} or GND.
For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.
This is the bus hold overdrive current required to force the input to the opposite logic state.

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AC CHARACTERISTICS GND = 0V, $t_R = t_F = 2.5ns$, $C_L = 50pF$, $R_L = 500\Omega$; $T_{amb} = -40^{\circ}C$ to +85°C.

				l	LIMITS		
SYMBOL	PARAMETER	WAVEFORM	Vcc	₂ = 3.3V ± 0).3V	V _{CC} = 2.7V	
			MIN	TYP ¹	MAX	MAX	
f _{MAX}	Maximum clock frequency	1	150	180			MHz
t _{PLH} t _{PHL}	Propagation delay CPAB to Bn or CPBA to An	1	1.8 2.1	3.8 3.8	5.7 5.7	6.7 6.4	ns
t _{PLH} t _{PHL}	Propagation delay An to Bn or Bn to An	2	1.3 1.0	2.8 2.7	4.7 4.6	5.4 5.3	ns
t _{PLH} t _{PHL}	Propagation delay SAB to Bn or SBA to An	2 3	1.4 1.4	3.7 3.8	6.2 6.2	7.2 6.8	ns
t _{PZH} t _{PZL}	Output enable time OE to An or Bn	5 6	1.0 1.0	4.0 4.1	5.8 6.0	7.2 7.3	ns
t _{PHZ} t _{PLZ}	Output disable time OE to An or Bn	5 6	2.3 2.2	4.3 3.8	6.5 5.8	6.9 5.9	ns
t _{PZH} t _{PZL}	Output enable time DIR to An or Bn	5 6	1.0 1.2	3.4 3.4	6.5 6.3	7.5 7.1	ns
t _{PHZ} t _{PLZ}	Output disable time DIR to An or Bn	5 6	1.7 1.5	4.1 3.5	7.2 5.8	8.1 6.3	ns

NOTE:

1. All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.

AC SETUP REQUIREMENTS

GND = 0V, t_R =2.5ns, t_F = 2.5ns, C_L = 50pF, R_L = 500 Ω ; T_{amb} = -40°C to +85°C

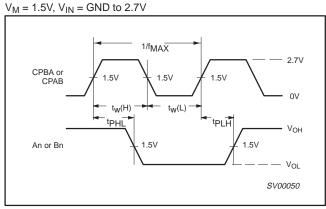
					LIMITS	
SYMBOL	PARAMETER	WAVEFORM	V _{CC} = 3.	3V± 0.3V	V _{CC} = 2.7V	UNIT
			Min	Тур	Min	
t _s (H) t _s (L)	Setup time ¹ An to CPAB, Bn to CPBA	4	1.5 2.0	1.0 1.0	1.6 2.4	ns
t _h (H) t _h (L)	Hold time ¹ An to CPAB, Bn to CPBA	4	0.0 0.0	-1.0 -1.0	0.0 0.0	ns
t _w (H) t _w (L)	Pulse width, High or Low CPAB or CPBA	1	3.3 3.3	1.0 2.0	3.3 3.3	ns

NOTE:

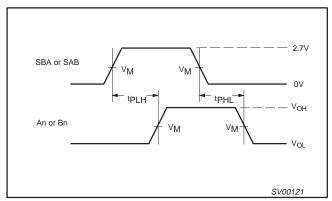
1. This data sheet limit may vary among suppliers.

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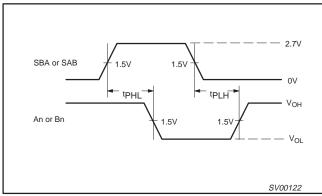
AC WAVEFORMS



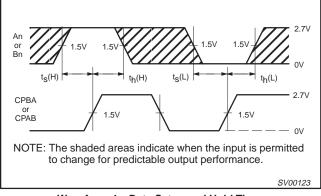
Waveform 1. Propagation Delay, Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency



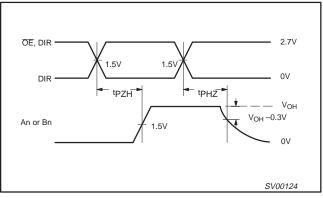
Waveform 2. Propagation Delay, SAB to Bn or SBA to An, An to Bn or Bn to An



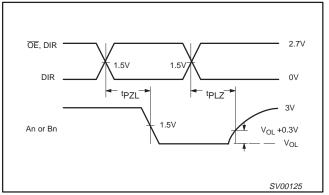
Waveform 3. Propagation Delay, SBA to An or SAB to Bn



Waveform 4. Data Setup and Hold Times



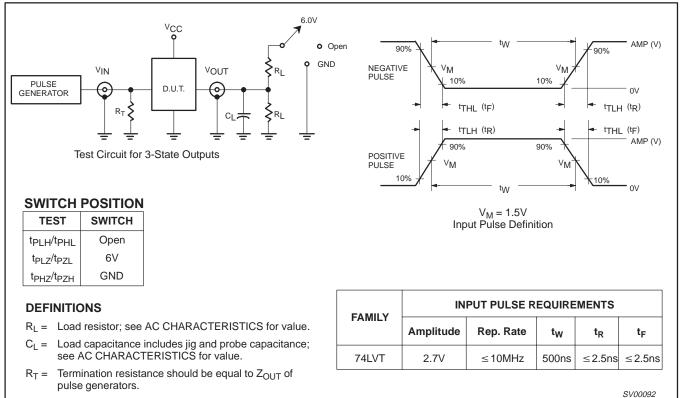


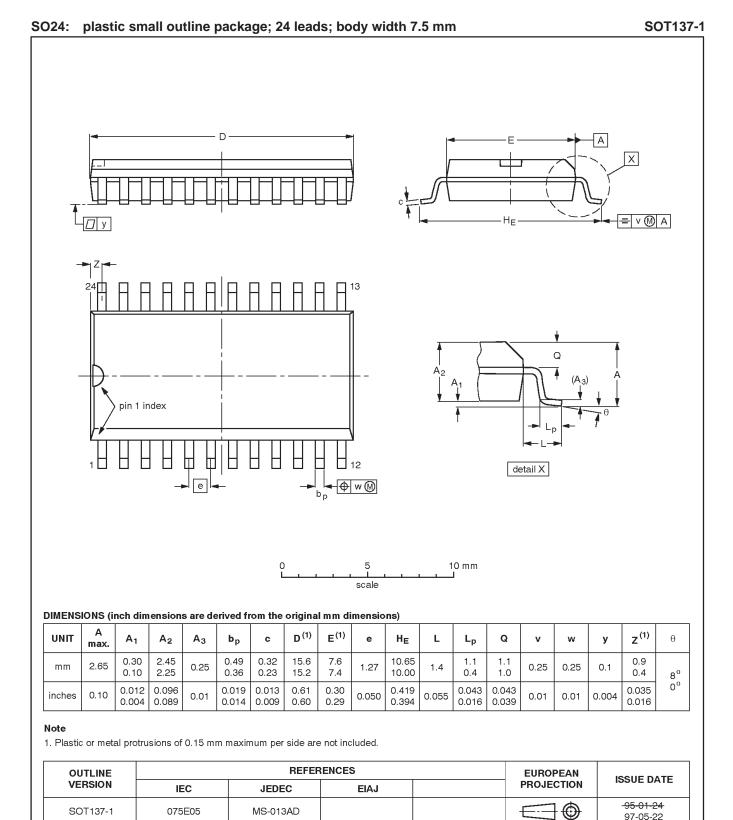


Waveform 6. 3-State Output Enable Time to Low Level and **Output Disable Time from Low Level**

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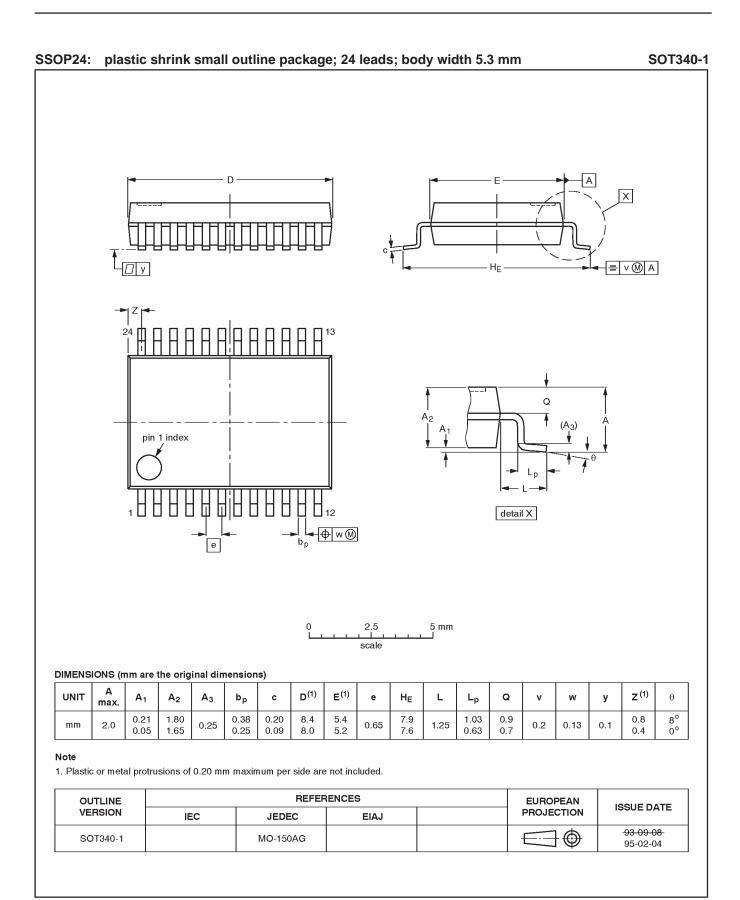
TEST CIRCUIT AND WAVEFORM



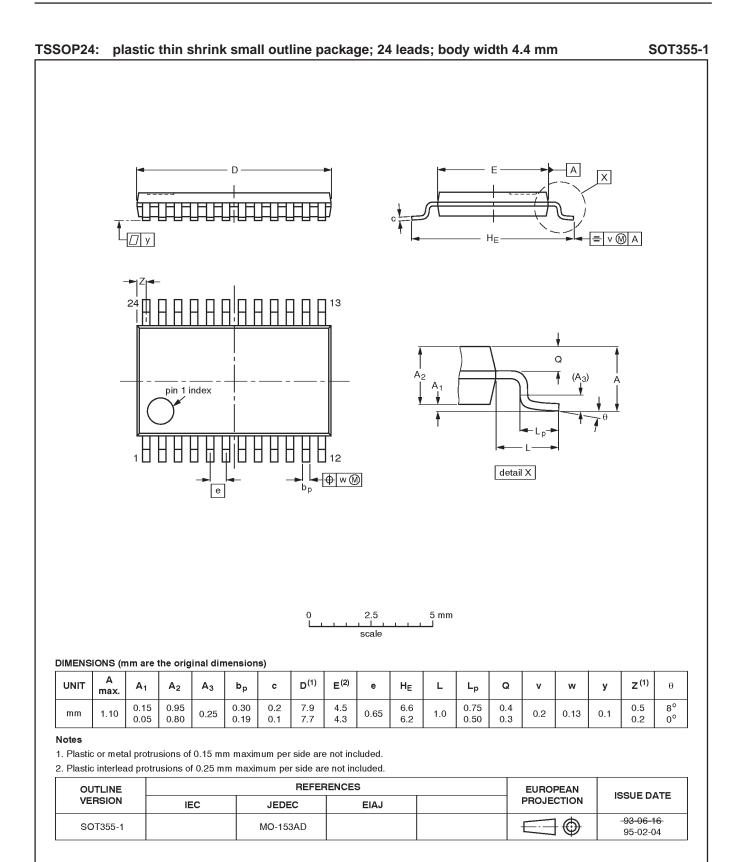


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Product specification

NOTES

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Data sheet status

Data sheet status	Product status	Definition ^[1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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print code

Document order number:

9397-750-03544

Date of release: 05-96

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